

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/655,900	SHIUE ET AL.	
Examiner	Art Unit	
Saved T. Zewari	2617	

SEARCHED					
Class	Subclass	Date	Examiner		
455	575.300	1/20/2006	STZ		
455	575.300	1/20/2006	STZ		
455	575.8	1/20/2006	STZ		
455	550.1	1/23/2006	STZ		
455	90.3	1/23/2006	STZ		
455	updated	4/17/2006	STZ		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH I (INCLUDING SEAR	NOTES CH STRATEGY	')
	DATE	EXMR
Nick Corsaro	1/20/2006	STZ